

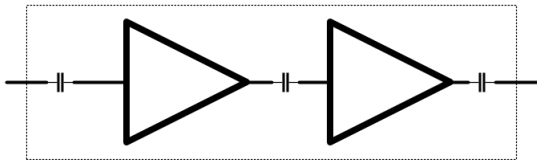
## Product Overview

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The ASL5006 is a GaN MMIC Low Noise Amplifier (LNA) chip which operates from 5 to 6 GHz. The ASL5006 features extremely flat performance characteristics including 16.5 dB of small signal gain, 2.18 dB of noise figure, output IP3 of +37 dBm and output P1dB of 21.5 dBm across the operating band. With a reflective power limiter, the ASL5006 has a power handling capacity of 37.5 dBm continuous wave (CW). Also, ASL5006 can be switched on/off with a digital voltage of 0/3.3 V. This versatile LNA is ideal for hybrid and MCM assemblies due to its compact size, consistent output power and DC blocked RF I/O's. All data is measured with the chip in a 50 Ohm test fixture connected via two 0.025 mm (1 mil) diameter bond wires of minimal length 0.51 mm (20 mil).

## Functional Block Diagram

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## Key Features

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1. Integrated DC blocking at RF input/output
2. Enable/Disable mode with digital signal
3. Bandwidth: 5 GHz to 6 GHz
4. Small Signal Gain : 16.5 dB
5. Noise Figure: 2.18 dB
6. Output P1dB: 21.5 dBm
7. Output TOI: 37 dBm
8. Input Power Handling: 37.5 dBm(CW), 40.5 dBm (Pulsed)
9. 50 Ohm Matched Input/output
10. Die Size: 3.5 x 1.5 x 0.1 mm

## Applications

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1. Instrumentation
2. Point-to-point communication

## Absolute Maximum Rating

Drain Bias Voltage (VDD)	+40 Vdc
Gate Bias Voltage (VSS)	-10 Vdc
RF Input Power (CW)	37.5 dBm
RF Input Power (Pulsed)	40.5 dBm
Channel Temperature	200 °C
Continuous P <sub>diss</sub> (T = 85 °C)	1.5 W
Storage Temperature	-65 to +150 °C
Operating Temperature	-40 to +65 °C



ELECTROSTATIC SENSITIVE DEVICE OBSERVE HANDLING PRECAUTIONS

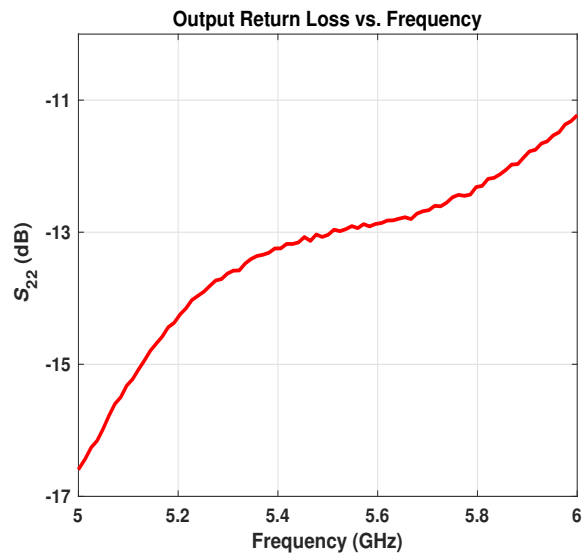
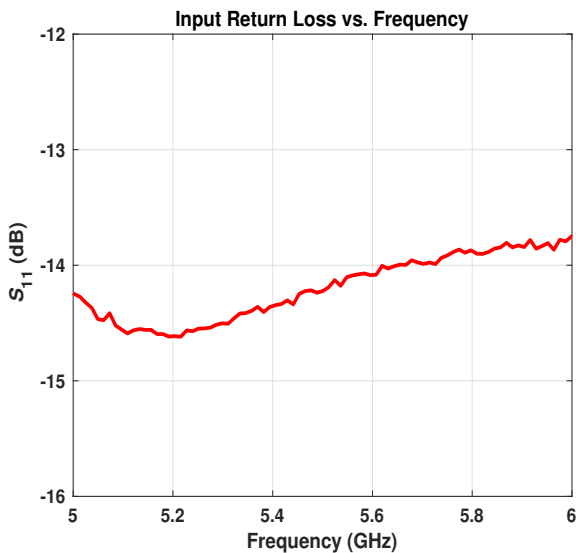
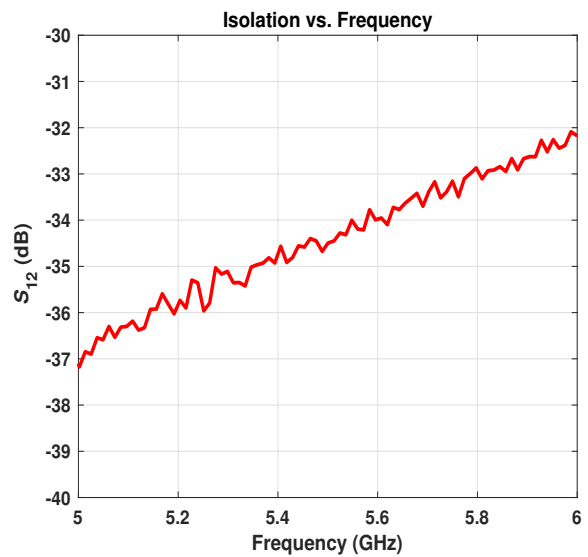
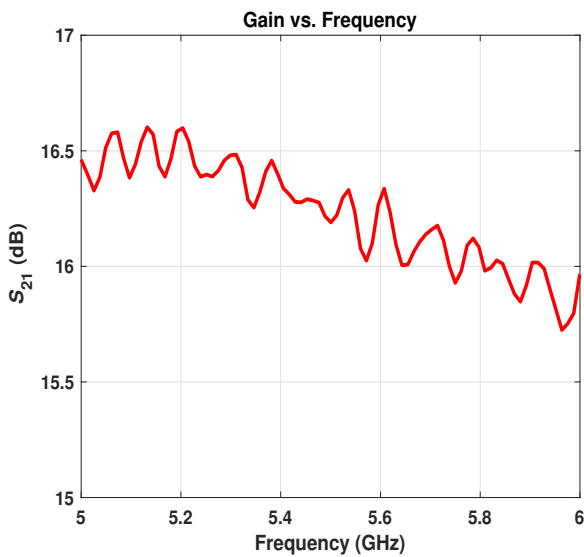
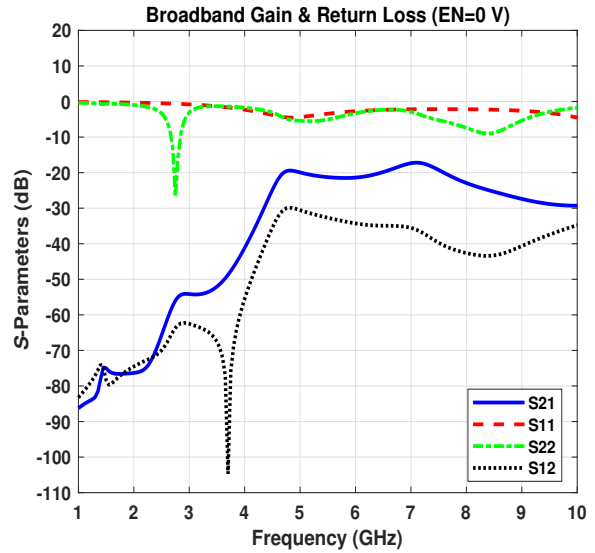
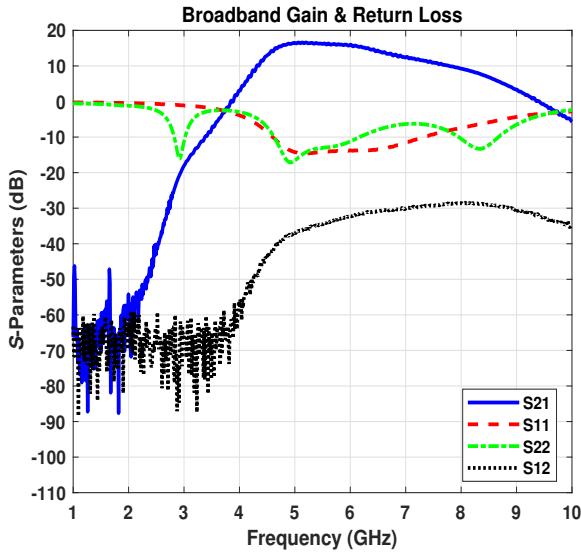
## Electrical Specifications

Parameter	Min.	Typ.	Max.	Units
Frequency Range	5	-	6	GHz
Gain	15.8	16	16.5	dB
Noise Figure	2.18	2.3	2.58	dB
Input Return Loss	-	14	-	dB
Output Return Loss	-	13	-	dB
Output Power for 1 dB Compression (P <sub>1dB</sub> )	-	21.5	-	dBm
Saturated Output Power	-	23.8	-	dBm
Output Third Order Intercept Point (IP <sub>3</sub> )	-	37	-	dBm
Supply Current (with RF)	-	85	-	mA

Test conditions unless otherwise noted: TA=+25° C, VDD=10 V, VSS=-6 V, EN=3.3 V, ID=85 mA, Z<sub>0</sub>=50 Ω  
T<sub>case</sub> is Cold Plate temperature, and Base Plate temperature (TBP) is 85°C.

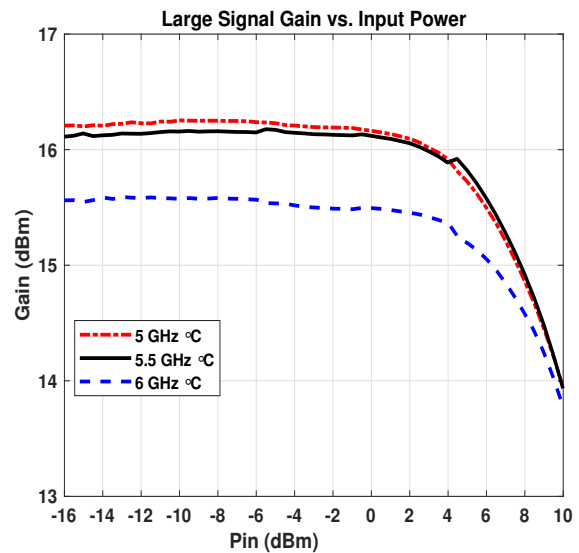
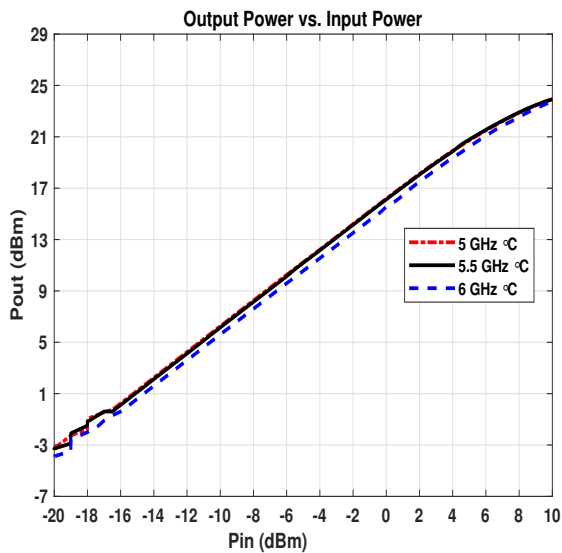
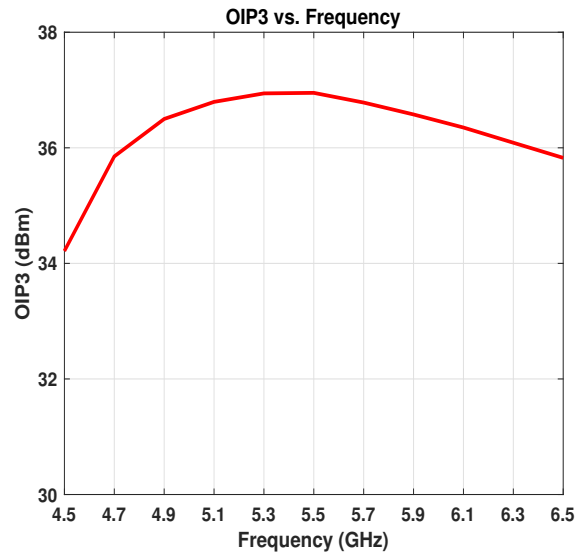
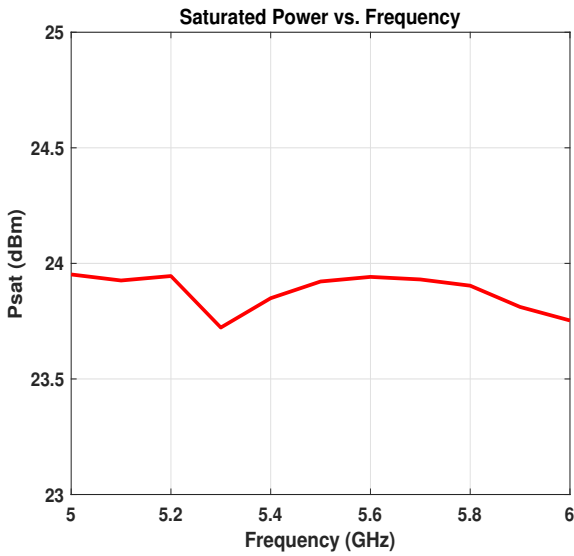
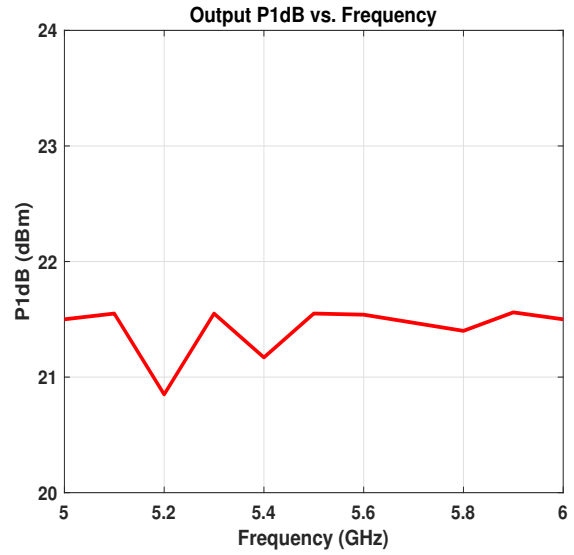
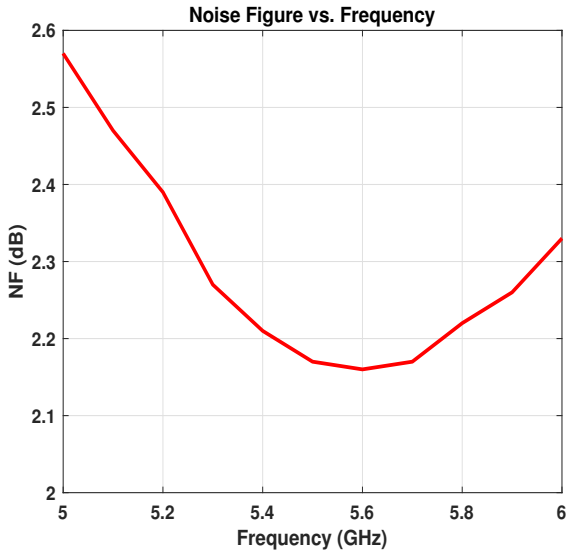
## Typical Performance Curves

Test conditions unless otherwise noted: VDD=10 V, VSS=-6 V, EN=3.3 V

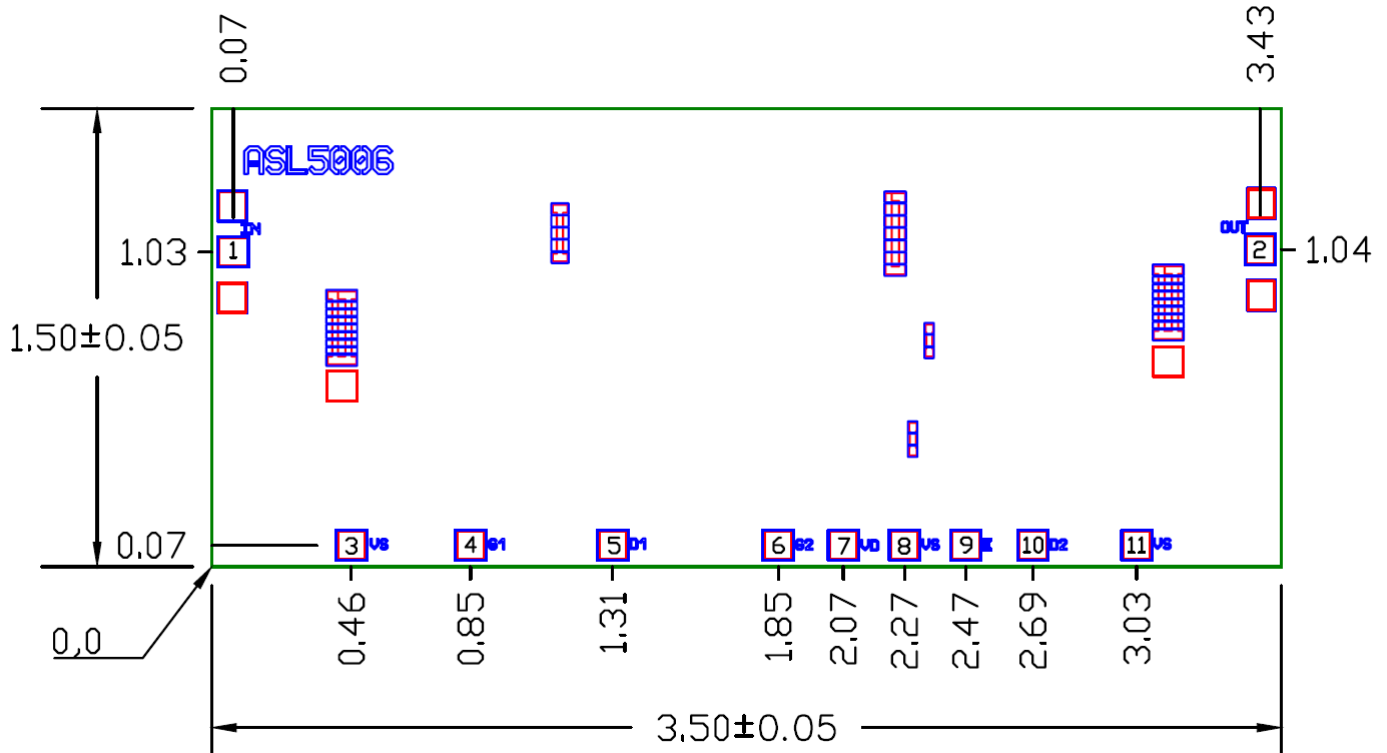


## Typical Performance Curves

Test conditions unless otherwise noted: VDD=10 V, VSS=-6 V, EN=3.3 V



## Mechanical Information



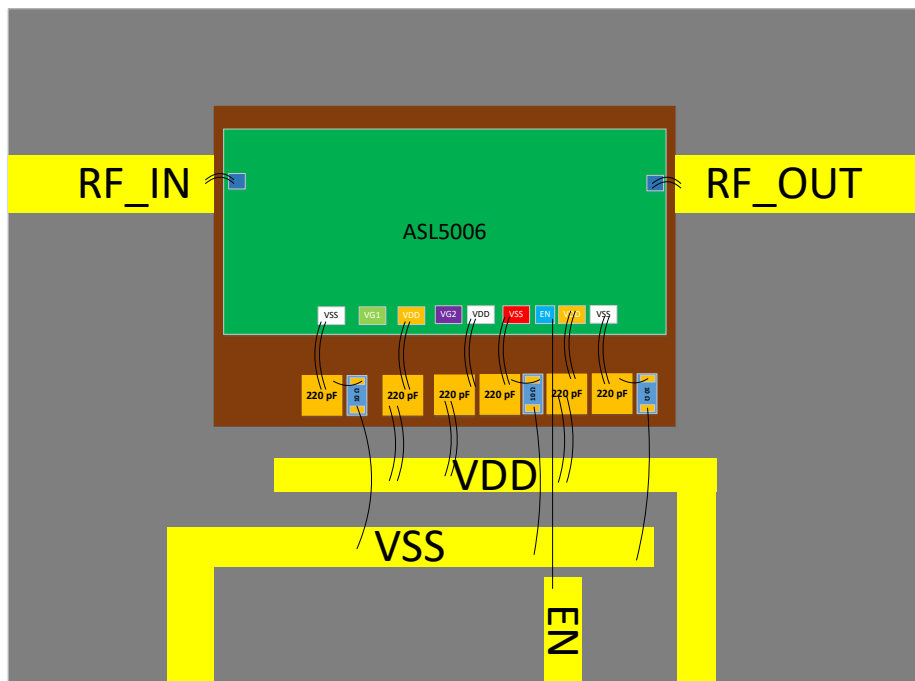
### NOTES:

1. ALL DIMENSIONS ARE IN MILLIMETERS
2. CHIP SIZE = 3.5 mm × 1.5 mm (DICING STREET INCLUDED) ± 0.05 mm
3. RF pads (1,2) = 0.1 × 0.1 mm
4. DC pads (3,4,5,6,7,8,9,10,11) = 0.1 × 0.1 mm
5. BACKSIDE METALLIZATION: GOLD
6. BACKSIDE METAL IS GROUND
7. BOND PAD METALIZATION: GOLD
8. NO CONNECTION REQUIRED FOR UNLABELED BOND PADS
9. OVERALL DIE SIZE ±50 μm

## Bond Pad Description

1	RF-IN	This pad is AC coupled and matched to 50 Ohms.
2	RF-OUT	This pad is AC coupled and matched to 50 Ohms.
3,11	VSS	Negative Supply Voltage for the amplifier.
4,6	-	Not Connected.
5,10	VDD	Positive Supply Voltage for the amplifier. External bypass capacitors of 220 pF or 150 pF are required.
7	VDD	Positive Supply Voltage for the amplifier. External bypass capacitors of 220 pF or 150 pF are required.
8	VSS	Negative Supply Voltage for the amplifier.
9	EN	This pad is for enabling/disabling of amplifier. A digital signal 0/3.3V. This pad is pulled down internally.

## Assembly Diagram



## Assembly Notes

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### Component Placement and Adhesive Attachment Assembly Notes:

1. Use vacuum collet to pick up the die.
2. The force should be controlled during placement and mounting specially no force should be applied to air bridges.

### Reflow process assembly notes:

1. Use CMC or MoCu carrier to decrease thermal expansion mechanical stress
2. Use AuSn (80/20) solder and limit exposure to temperatures above 300 °C to 3-4 minutes, maximum.
3. An alloy station or conveyor furnace with reducing atmosphere should be used.
4. Do not use any kind of flux.
5. Devices must be stored in a dry nitrogen atmosphere.
6. Use Au bond wire.

## Contact Information

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For the latest specifications, additional product information:

Web: [www.abba-semi.com](http://www.abba-semi.com)

Email: [info@abba-semi.com](mailto:info@abba-semi.com)